

Enhanced Interpretable Knowledge Tracing *for* Students' Performance Prediction with Human-understandable Feature Space

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Abstract. Knowledge Tracing (KT) plays a central role in assessing students' skill mastery and predicting their future performance. While deep learning-based KT models achieve superior predictive accuracy compared to traditional methods, their complexity and opacity hinder their ability to provide psychologically meaningful explanations. This disconnect between model parameters and cognitive theory poses challenges for understanding and enhancing the learning process, limiting their trustworthiness in educational applications. To address these challenges, we enhance interpretable KT models by exploring human-understandable features derived from students' interaction data. By incorporating additional features, particularly those reflecting students' learning abilities, our enhanced approach improves predictive accuracy while maintaining alignment with cognitive theory. Our contributions aim to balance predictive power with interpretability, advancing the utility of adaptive learning systems.

Keywords: Knowledge tracing, student modeling, Bayesian networks, causality, feature engineering

1 Introduction

Adaptive learning systems have revolutionized modern education by dynamically adjusting to each learner's requirements in real time [5, 8, 9]. However, implementing such personalized learning at scale presents significant challenges, where intelligent tutoring systems must effectively assess and adapt to the learning trajectories of tens or even hundreds of thousands of students [16].

KT models are the backbone of intelligent tutoring systems, driving personalized content delivery and feedback. Artificial Intelligence (AI) plays a critical role in this process, with KT models using machine learning techniques to infer a student's conceptual and procedural knowledge based on their task performance [1, 10]. Among KT methods, Deep Knowledge Tracing (DKT) [20] stands out for its use of Neural Networks (NNs), which model student learning over time and

deliver superior predictive performance, highlighting the transformative impact of deep learning in education [20, 11, 7].

Bayesian Knowledge Tracing (BKT) [1], an earlier and interpretable KT model, utilizes a Hidden Markov Model to track a student’s knowledge state. In contrast, DKT overcomes this limitation by using NNs to model cross-skill dynamics, improving predictive accuracy. Despite its improved performance, DKT’s reliance on complex hidden layers and large numbers of parameters reduces its interpretability, making it less transparent and trustworthy for educators. The lack of interpretability in models like DKT highlights the need for methods that combine accurate predictions with clear, actionable insights. Toward a transparent, psychologically meaningful model, we aim to extend IKT [16], focusing on simplicity while maintaining comparable predictive performance.

2 Exploring human-understandable feature space

Drawing inspiration from the Interpretable Knowledge Tracing (IKT) model [16], we propose an Enhanced Interpretable Knowledge Tracing (EIKT) model that introduces a richer and more interpretable feature space through advanced feature extraction. The IKT model predicts a student’s future responses using three core latent features: individual skill ID, skill mastery, and problem difficulty. Beyond this foundation, EIKT incorporates enhanced ability profiling to explore the interplay between item difficulty and skill correctness.

Skill Mastery In a typical BKT-based learning environment [1], a student’s skill mastery is dynamically updated with each item’s response. BKT operates using four key probabilities: **Initial Knowledge** ($P(L_0)$): The probability that a student already knows the skill before any practice; **Learning** ($P(T)$): The probability that the student will transition from not knowing the skill to knowing it after an opportunity to practice; **Guess** ($P(G)$): The probability that the student correctly answers an item despite not having mastered the skill; **Slip** ($P(S)$): The probability that the student incorrectly answers an item despite having mastered the skill.

The probability that a student knows the skill at any given time t is continuously updated based on their observed outcomes, recorded as either successful (Obs = 1) or unsuccessful (Obs = 0). This iterative update mechanism allows BKT to provide a dynamic and data-driven assessment of a student’s evolving knowledge state.

$$P(L_t|1) = \frac{P(L_t)(1 - P(S))}{P(L_t)(1 - P(S)) + (1 - P(L_t))P(G)} \quad (1)$$

$$P(L_t|0) = \frac{P(L_t)P(S)}{P(L_t)P(S) + (1 - P(L_t))(1 - P(G))} \quad (2)$$

$$P(L_{t+1}) = P(L_t|obs) + (1 - P(L_t|obs))P(T) \quad (3)$$

$$\mathbf{skill\ mastery}(s_t) = \delta(P(L_t), s_t) \quad (4)$$

In this context, $\delta(P(L_t), s_t)$ represents a function that maps the mastery level of a specific skill s_t at the current timestamp, based on the student’s cumulative interaction history.

Problem Difficulty serves as a distinct feature for predicting student performance in previous studies [18, 11, 16]. The difficulty of a problem p_j is determined on a scale of 1 to 10. Problem difficulty $\mathbf{Pd}(P_j)$ is calculated as:

$$\mathbf{Pd}(p_j) = \begin{cases} \delta(p_j) & \text{if } |N_j| \geq 4 \\ 5 & \text{otherwise} \end{cases} \quad (5)$$

$$\delta(p_j) = \left\lfloor \frac{\sum_i^{|N_j|} O_i(p_j)}{|N_j|} \cdot 10 \right\rfloor \quad (6)$$

and where p_j represents the j^{th} problem; N_j is the set of students who attempted problem p_j ; $O_i(p_j)$ the outcome of the first attempt from student i to problem p_j , 1 if successful, 0 otherwise. $\delta(p_j)$ is a function that maps the *average success rate* of problem p_j onto 10 levels.

Ability Profile: Learners trajectory Approaches like DKT-DSC and IKT [17, 16] introduced the use of cluster IDs as an ability profile, first applied in deep learning-based models and later extended to Tree-Augmented Naive Bayes (TAN). While clustering offers a cost-efficient solution for deep learning-based models, it may sacrifice some predictive accuracy.

To address these challenges, we reformulate the *ability profile* by directly introducing two types based on problem difficulty and skill correctness. This enhancement improves the model’s ability to track and adapt to student learning over time.

- **Skill Correctness-based Ability Profile** is calculated to represent a student’s cumulative ability in mastering the skill associated with the current problem. This measure provides valuable insights into a student’s skill-specific strengths and weaknesses, enabling personalized learning interventions.

$$sr_profile = R(x_j)_{1:t} = \sum_{t=1}^z \frac{(x_{jt})}{|N_{jt}|}, \quad (7)$$

where x_{jt} is the total correct outcome of attempt of skill x_j of the problem being correctly answered at timestamp t ; $|N_{jt}|$ is the total number of practice attempts of skill x_j up to timestamp t ;

- **Item Difficulty-based Ability Profile** is calculated to represent a student’s cumulative ability in handling problems of varying difficulty levels. This metric helps in understanding how well a student performs across different difficulty tiers and provides a basis for adaptive instructional strategies tailored to their proficiency.

$$df_profile = R(\mathbf{Pd}(p_j))_{1:t} = \sum_{t=1}^t \frac{(\mathbf{Pd}(p_{jt}))}{|N_{jt}|}, \quad (8)$$

where $\mathbf{Pd}(p_{jt})$ is the total correct outcome of the attempts to problem difficulty level like current problem (p_j) being correctly answered until timestamp t ; $|N_{jt}|$ is the total number of practice attempts of problem difficulty level like current problem $\mathbf{Pd}(p_j)$ up to timestamp t .

Instead of utilizing a cluster ID as an ability profile, as done in DKT-DSC and IKT, we employed a more refined ability profile derived from two key dimensions: item difficulty and skill correctness. This approach captures the cumulative ability of a student by leveraging their performance on problems categorized by difficulty levels and specific skills.

3 Predicting student performance

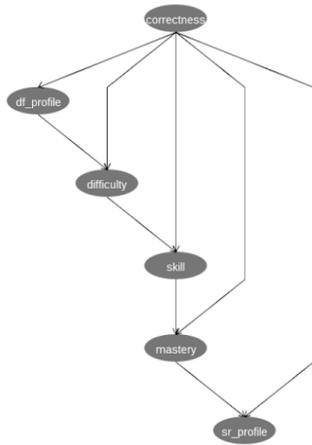


Fig. 1. Tree Structure of TAN for EIKT.

all terms by student i , s_t , P_j in Figure 1 and Equation 9).

Inspired by Interpretable Knowledge Tracing (IKT), we employ the Tree-Augmented Naive Bayes (TAN) method [3, 14]. TAN extends the Naive Bayes network by designating the class node representing problem correctness as the root, causally connected to evidence nodes such as skill ID, skill mastery, ability profile, and problem difficulty. As shown in Figure 1, this approach maintains the directed acyclic graph (DAG) structure [4, 12, 13], ensuring efficient reasoning while retaining interpretability.

EIKT¹ performs inference by using five meaningful features f_t : skill ID (skill), skill mastery (mastery), skill correctness-based ability profile (sr_profile), item Difficulty-based ability profile (df_profile), and problem difficulty (difficulty) as evidenced at the current timestamp t (for brevity we omit indexing

¹ The source code and data for replicating our experiments are available at <https://github.com/Simon-tan/IKT.git>

$$P(\text{correctness}_t = y|f_t) = \frac{P(y)P(f_t|y)}{\sum_{y'} P(y')P(f_t|y')} \quad (9)$$

where $P(f_t|y) = P(\text{df_profile}|y)P(\text{diffiucly}|y, \text{df_profile})P(\text{skill}|y, \text{diffiucly})$
 $P(\text{mastery}|y, \text{skill})P(\text{sr_profile}|y, \text{mastery})$

The class node (correctness) represents the predicted probability that the student would correctly answer the problem with the associated skill as described in Figure 1. We can achieve interpretation via the conditional probability tables of each node with their causal links [15].

The primary computational cost arises from extracting skill mastery using Bayesian Knowledge Tracing (BKT), while training the TAN model takes only a few seconds. Consequently, the overall training cost of our approach remains effectively equivalent to that of BKT, with the TAN modeling cost being negligible. Unlike IKT, our approach eliminates profile clustering, thereby reducing the computational expenses associated with clustering. This allows EIKT to significantly lower model complexity, training time, and computational costs compared to deep learning models while providing causal explanations for greater interpretability.

4 Experiments

We compare the next problem student performance prediction of our model with well-known KT models mentioned above: BIRT [21], BKT [1], PFA [19], DKT [20], DKT-DSC [17], DKVMN [22], AKT-R [6] and IKT [16]. To validate the proposed model, we conducted experiments using three public datasets from two distinct computer-based tutoring scenarios in educational settings: ASSISTments: 1) ASSISTments 2009-2010 (Skill Builder) 2) ASSISTments 2012-2013 [2]² and Cognitive Tutor Algebra 2005-2006 (KDD Cup 2010) dataset on PSLC DataShop³. For all datasets, only the first correct attempts to original problems are considered in our experiment. We remove data with missing values for skills and problems with duplicate records. We used five-fold cross-validation to evaluate all datasets, splitting each fold into 80% training and 20% testing students. To the best of our knowledge, these are among the most well known publicly available knowledge tracing datasets.

Results The EIKT structure results in a student model with better explanation with causal relations and higher predictive performance. The results in Tables 1 demonstrate that EIKT outperforms significantly the well-known KT models in all tested datasets. When we compare EIKT with our second-best performer IKT and AKT-R (scores are underlined in table 1). EIKT shows slightly better

² <https://sites.google.com/site/assistmentsdata/>

³ <https://pslclatashop.web.cmu.edu/KDDCup/downloads.jsp>

Type	Datasets	BIRT	PFA	BKT	DKT	DKT-DSC	DKV-MN	AKT-R	IKT	EIKT
AUC	ASS-09	0.750	0.701	0.651	0.721	0.735	0.710	0.767	<u>0.797</u>	0.801
	ASS-12	0.744	0.672	0.623	0.713	0.721	0.707	0.777	0.767	<u>0.773</u>
	Algebra	0.812	0.754	0.642	0.784	0.792	0.780	<u>0.845</u>	<u>0.845</u>	0.848
	Average	0.768	0.709	0.638	0.739	0.749	0.732	0.796	<u>0.802</u>	0.806
RMSE	ASS-09	0.440	0.454	0.471	0.450	0.434	0.451	0.423	<u>0.412</u>	0.411
	ASS-12	0.441	0.440	0.510	0.430	0.427	0.430	0.409	<u>0.412</u>	<u>0.412</u>
	Algebra	0.374	0.391	0.440	0.380	0.373	0.380	<u>0.357</u>	<u>0.358</u>	0.356
	Average	0.418	0.428	0.473	0.420	0.411	0.420	0.396	<u>0.395</u>	0.394

Best scores are in bold, second-best scores are underlined.

Table 1. Average AUC and RMSE result for all tested models across datasets.

performance than IKT but has superior performance compared to other models tested in our experiments. the improvement is ranging from 0.12% to 0.78% in terms of AUC. When we compare in terms of RMSE, it still keeps almost the same performance as IKT but shows better performance than other models. So EIKT shows better performance than any other method in both AUC and RMSE (except AKT-R on the ASS-12 dataset).

5 Conclusion

Unlike the cluster-ID used as an ability profile in IKT, we introduce two enhanced ability profiles that improve student performance prediction while preserving model interpretability. By incorporating these features into the Tree-Augmented Naïve Bayes (TAN) structure with explicit causal relationships, we develop a Knowledge Tracing (KT) model that achieves superior predictive accuracy without relying on extensive parameters or complex architectures.

We propose a causal probabilistic student model, EIKT, which integrates five key features: skill ID, student skill mastery (probability of mastering a skill), two ability profiles (based on problem difficulty and skill correctness), and problem difficulty. Unlike deep learning-based KT models that rely on hidden states, numerous parameters, and complex architectures, EIKT leverages explicit, interpretable features derived from skills, problems, and students, enhancing predictive accuracy and causal interpretability. By eliminating profile clustering, EIKT further reduces the computational expenses required in IKT, making it even more efficient. Experiments on three public datasets demonstrate that EIKT outperforms established KT models, including deep learning approaches, while maintaining significantly lower computational costs. The integration of carefully engineered features captures greater data variance, while the TAN framework provides causal insights. By incorporating skill mastery, ability

profiles, and problem difficulty, EIKT effectively accounts for student variability, enabling more personalized and accurate predictions.

While our primary focus is on prediction accuracy, we also highlight the importance of understanding the causal effects of explainable features to inform adaptive instruction in personalized learning systems. Future work will explore knowledge acquisition and learning behaviors to further optimize human learning in evolving educational environments.

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